IGBT with Monolithic Free Wheeling Diode

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, provides superior performance in demanding switching applications, and offers low on–state voltage with minimal switching losses. The IGBT is well suited for resonant or soft switching applications.

Features

- Extremely Efficient Trench with Fieldstop Technology
- 1350 V Breakdown Voltage
- Optimized for Low Losses in IH Cooker Application
- Reliable and Cost Effective Single Die Solution
- These are Pb-Free Devices

Typical Applications

- Inductive Heating
- Consumer Appliances
- Soft Switching

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage @ T _J = 25°C	e @ V _{CES} 1350		V
Collector current @ Tc = 25°C @ Tc = 100°C	Ι _C	60 30	Α
Pulsed collector current, T_{pulse} limited by T_{Jmax} 10 μs pulse, V_{GE} = 15 V	I _{CM}	120	Α
Diode forward current @ Tc = 25°C @ Tc = 100°C	I _F	60 30	A
Diode pulsed current, T_{pulse} limited by T_{Jmax} 10 μs pulse, V_{GE} = 0 V	I _{FM}	120	Α
Gate-emitter voltage Transient Gate-emitter Voltage (T _{pulse} = 5 μs, D < 0.10)	$V_{\sf GE}$	±20 ±25	V
Power Dissipation @ Tc = 25°C @ Tc = 100°C	P_D	394 197	W
Operating junction temperature range	TJ	-40 to +175	°C
Storage temperature range	T _{stg}	-55 to +175	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T _{SLD}	260	°C

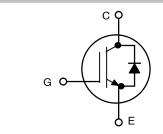
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

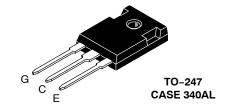


ON Semiconductor®

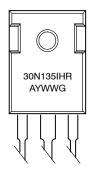
http://onsemi.com

30 A, 1350 V V_{CEsat} = 2.30 V E_{off} = 0.85 mJ





MARKING DIAGRAM



A = Assembly Location

Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

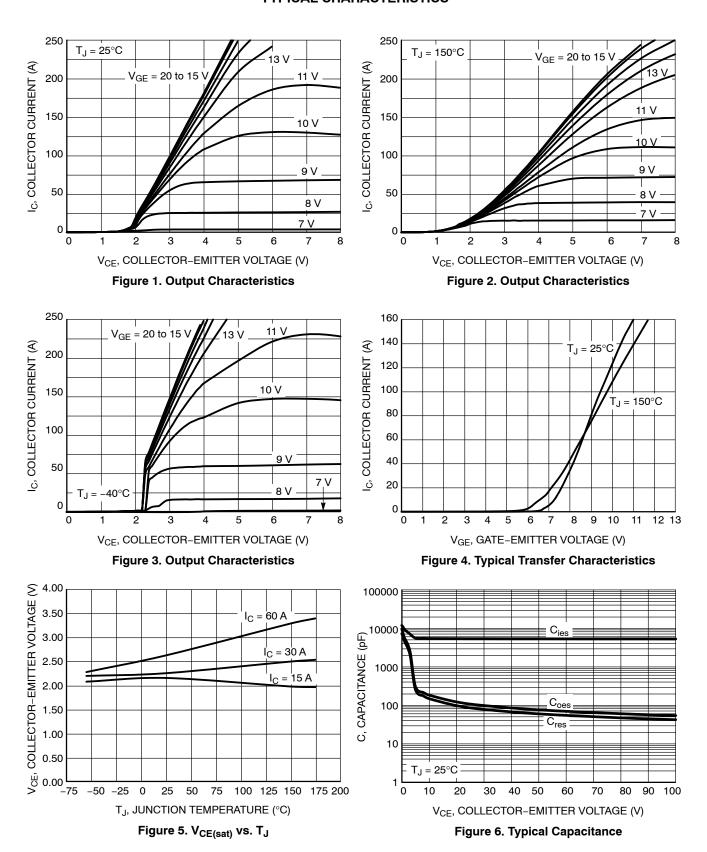
Device	Package	Shipping
NGTB30N135IHRWG	TO-247 (Pb-Free)	30 Units / Rail

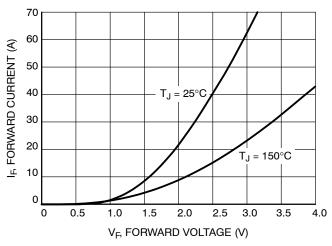
THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case	$R_{ heta JC}$	0.38	°C/W
Thermal resistance junction-to-ambient	$R_{ heta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC						
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V, I}_{C} = 5 \text{ mA}$	V _{(BR)CES}	1350	_	=	V
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 30 A V _{GE} = 15 V, I _C = 30 A, T _J = 175°C	V _{CEsat}	- -	2.30 2.50	2.65 -	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}, I_{C} = 250 \mu A$	V _{GE(th)}	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	V _{GE} = 0 V, V _{CE} = 1350 V V _{GE} = 0 V, V _{CE} = 1350 V, T _{J =} 175°C	I _{CES}	- -	_ _	0.5 2.0	mA
Gate leakage current, collector-emitter short-circuited	te leakage current, collector-emitter V_{GE} = 20 V, V_{CE} = 0 V		-	_	100	nA
DYNAMIC CHARACTERISTIC						
Input capacitance		C _{ies}	-	5290	-	pF
Output capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{oes}	-	124	-	
Reverse transfer capacitance		C _{res}	-	100	-	
Gate charge total		Q_g	-	234	-	nC
Gate to emitter charge	V _{CE} = 600 V, I _C = 30 A, V _{GE} = 15 V	Q _{ge}	-	39	-	
Gate to collector charge		Q _{gc}	-	105	-	
SWITCHING CHARACTERISTIC, INDUCT	IVE LOAD					
Turn-off delay time	T _J = 25°C	t _{d(off)}	-	250	=	ns
Fall time	$V_{CC} = 600 \text{ V}, I_{C} = 30 \text{ A}$ $R_{q} = 10 \Omega$	t _f	-	150	-	
Turn-off switching loss	V _{GE} = 0 V/ 15V	E _{off}	-	0.85	-	mJ
Turn-off delay time	T _J = 150°C	t _{d(off)}	ı	265	1	ns
Fall time	$V_{CC} = 600 \text{ V, I}_{C} = 30 \text{ A}$ $R_{q} = 10 \Omega$	t _f	ı	225	1	
Turn-off switching loss	V _{GE} = 0 V/ 15V	E _{off}	-	1.90	-	mJ
DIODE CHARACTERISTIC						
Forward voltage	$V_{GE} = 0 \text{ V}, I_F = 30 \text{ A}$ $V_{GE} = 0 \text{ V}, I_F = 30 \text{ A}, T_J = 175^{\circ}\text{C}$	V _F	- -	2.10 3.20	2.40	V

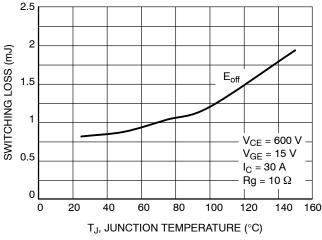




16 V_{GE}, GATE-EMITTER VOLTAGE (V) 14 12 10 6 V_{CE} = 600 V 2 V_{GE} = 15 V $I_C = 30 A$ 0 0 50 100 150 200 250 Q_G, GATE CHARGE (nC)

Figure 7. Diode Forward Characteristics

Figure 8. Typical Gate Charge



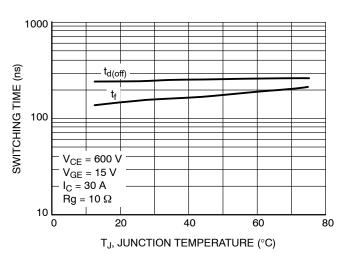
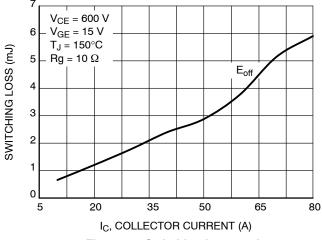


Figure 9. Switching Loss vs. Temperature

Figure 10. Switching Time vs. Temperature



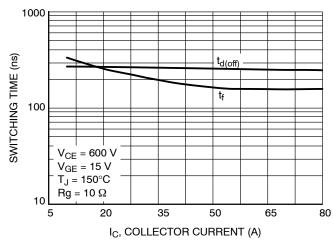
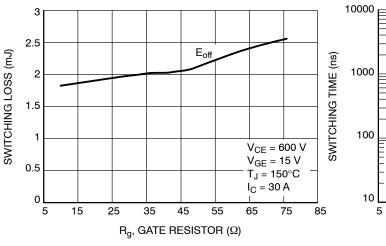


Figure 11. Switching Loss vs. I_C

Figure 12. Switching Time vs. I_C



10000

1000

V_{CE} = 600 V

V_{GE} = 15 V

T_J = 150°C

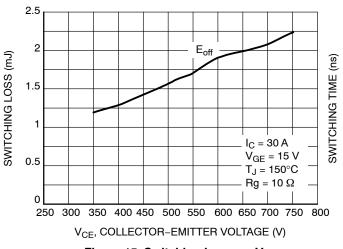
I_C = 30 A

5 15 25 35 45 55 65 75 85

R_g, GATE RESISTOR (Ω)

Figure 13. Switching Loss vs. Ra

Figure 14. Switching Time vs. R_g



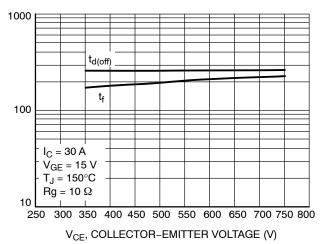
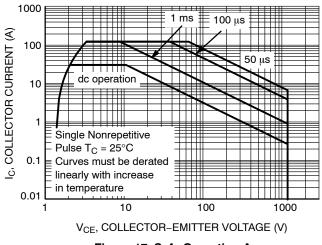


Figure 15. Switching Loss vs. V_{CE}

Figure 16. Switching Time vs. V_{CE}



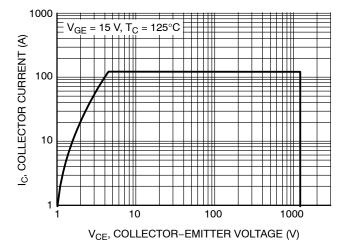


Figure 17. Safe Operating Area

Figure 18. Reverse Bias Safe Operating Area

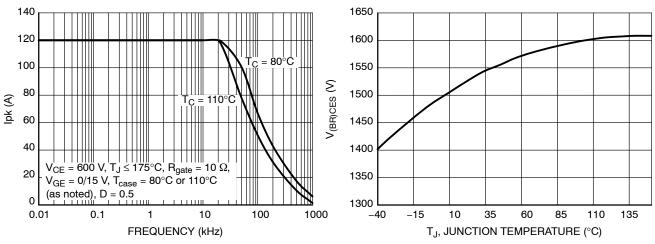


Figure 19. Collector Current vs. Switching Frequency

Figure 20. Typical $V_{(BR)CES}$ vs. Temperature

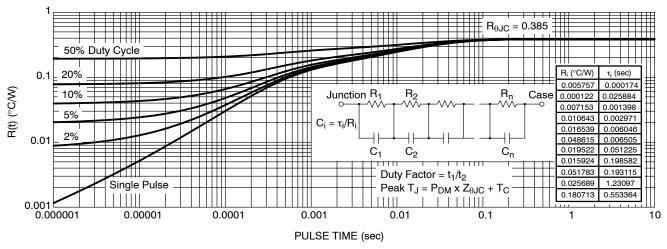


Figure 21. IGBT Transient Thermal Impedance

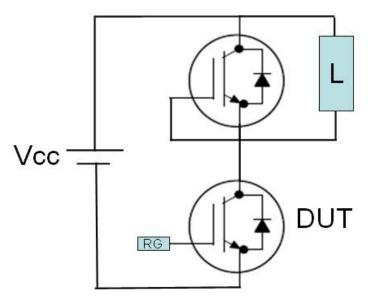


Figure 22. Test Circuit for Switching Characteristics

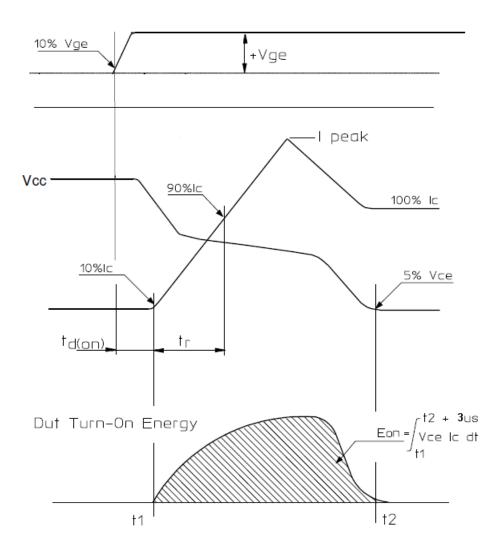


Figure 23. Definition of Turn On Waveform

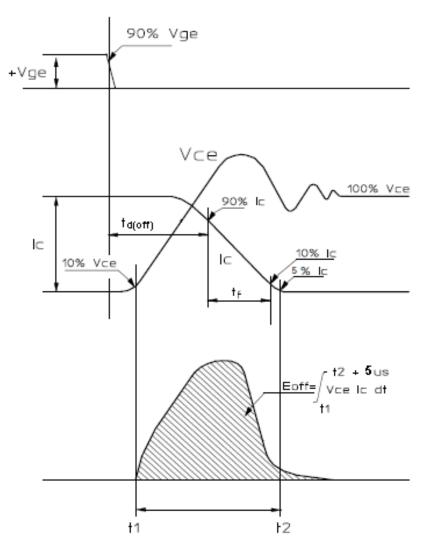
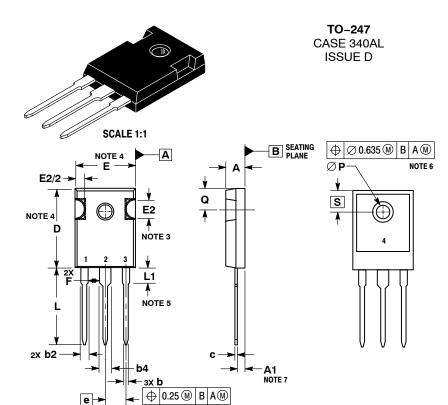


Figure 24. Definition of Turn Off Waveform



DATE 17 MAR 2017

- NOTES:

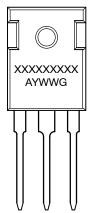
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. SLOT REQUIRED, NOTCH MAY BE ROUNDED.

 - DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH.
 MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY
- LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY
- ©P SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.

 DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED

	MILLIMETERS		
DIM	MIN	MAX	
Α	4.70	5.30	
A1	2.20	2.60	
b	1.07	1.33	
b2	1.65	2.35	
b4	2.60	3.40	
С	0.45	0.68	
D	20.80	21.34	
E	15.50	16.25	
E2	4.32	5.49	
е	5.45	BSC	
F	2.655		
L	19.80	20.80	
L1	3.81	4.32	
P	3.55	3.65	
Q	5.40	6.20	
S	6.15 BSC		

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

Υ = Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DOCUMENT NUMBER:	98AON16119F	Electronic versions are uncontrolled except when accessed directly from the Documen Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	TO-247		PAGE 1 OF 1

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at www.onsemi.com/support/sales